Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/522,559	DREFS ET AL.	
Examiner	Art Unit	
SANG KIM	3654	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
•	DATE	EXMR	
John Nguyen: 242/541.5	3/14/2007	sĸ	
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